


<b>Search Notes</b>  	<b>Application/Control No.</b>  10666815	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Neway, Samuel G	<b>Art Unit</b>  2626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST: Text Search, PLUS Search, Assignee Search, Inventor Search	02/13/07	SN
Consulted: T. Smits, AU 2626	02/15/07	SN
Consulted: Todd Swann, WQAS, TC 2100: regarding 101 issues.	02/16/07	SN
Consulted: T. Smits regarding 112, 2nd	07/30/07	SN
EAST: Updated Search	06/20/08	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
704	8	06/30/08	SN